

UNISONIC TECHNOLOGIES CO., LTD

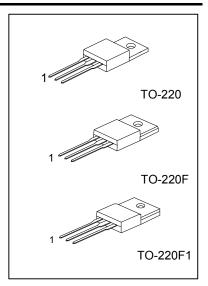
6N80 **Preliminary Power MOSFET**

6A, 800V N-CHANNEL **POWER MOSFET**

DESCRIPTION

The UTC 6N80 is a N-channel mode power MOSFET using UTC's advanced technology to provide customers with planar stripe and DMOS technology. This technology specialized in allowing a minimum on-state resistance and superior switching performance. It also can withstand high energy pulse in the avalanche and commutation mode.

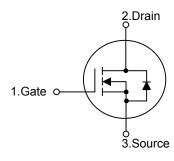
The UTC 6N80 is universally applied in high efficiency switch mode power supply.



FEATURES

- * $R_{DS(on)} = 2.0\Omega @V_{GS} = 10 \text{ V}$
- * Improved dv/dt capability
- * Fast switching
- * 100% avalanche tested

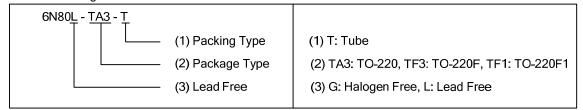
SYMBOL



ORDERING INFORMATION

Ordering Number		Dookogo	Pin Assignment			Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
6N80L-TA3-T	6N80G-TA3-T	TO-220	G	D	S	Tube	
6N80L-TF3-T	6N80G-TF3-T	TO-220F	G	D	S	Tube	
6N80L-TF1-T	6N80G-TF1-T	TO-220F1	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain S: Source



■ ABSOLUTE MAXIMUM RATINGS (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		$V_{ m DSS}$	800	V
Gate-Source Voltage		V_{GSS}	±30	V
Drain Current (Note 1)	Continuous	I _D	6	Α
	Pulsed	I _{DM}	22	Α
Avalanche Energy	Single Pulsed (Note 2)	E _{AS}	680	mJ
	Repetitive (Note 1)	E _{AR}	15.8	mJ
Peak Diode Recovery dv/dt (Note 3)		dv/dt	4.5	V/ns
Davis Diagination	TO-220	В	138	W
Power Dissipation	TO-220F/TO-220F1	P _D	51	W
Junction Temperature		TJ	+150	°C
Storage Temperature		T _{STG}	-55~+150	°C

- Note: 1. Repetitive Rating: Pulse width limited by maximum junction temperature
 - 2. L = 37mH, I_{AS} = 6A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25 $^{\circ}$ C
 - 3. $I_{SD} \le 5.5A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$
 - 4. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ THERMAL CHARACTERISTICS

PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient		θ_{JA}	62.5	°C/W
Junction to Case	TO-220		0.9	°C/W
	TO-220F/TO-220F1	θ _{JC}	2.45	°C/W

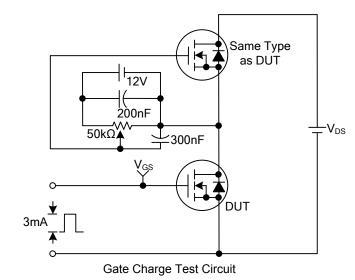
■ **ELECTRICAL CHARACTERISTICS** (T_C=25°C, unless otherwise specified)

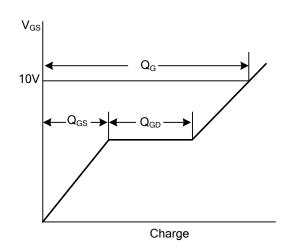
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS					•		
Drain-Source Breakdown Voltage		BV _{DSS}	I _D =250μA, V _{GS} =0V	800			V
Breakdown Voltage Temperature	Coefficient	$\triangle BV_{DSS}/\triangle T_{J}$	Reference to 25°C, I _D =250µA		0.97		V/°C
Drain-Source Leakage Current		I _{DSS}	V _{DS} =800V, V _{GS} =0V			10	
			V _{DS} =640V, T _C =125°C			100	μA
Cata Cauras Laglaga Current	Forward	699	V_{GS} =+30V, V_{DS} =0V			100	nA
Gate- Source Leakage Current	Reverse		V_{GS} =-30V, V_{DS} =0V			-100	nA
ON CHARACTERISTICS	ON CHARACTERISTICS						
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_D=250\mu A$	3.0		5.0	V
Static Drain-Source On-State Resi	stance	R _{DS(ON)}	V_{GS} =10V, I_D =3A		1.6	2.0	Ω
Forward Transconductance		g fs	V_{DS} =50V, I_D =3A (Note 1)		5.4		S
DYNAMIC PARAMETERS							
Input Capacitance		C _{ISS}	V _{GS} =0V, V _{DS} =25V,		1010	1310	pF
Output Capacitance		Coss	f=1.0MHz		90	115	pF
Reverse Transfer Capacitance		C _{RSS}	1-1.01/11/12		8	11	pF
SWITCHING PARAMETERS							
Total Gate Charge		Q_{G}	V _{GS} =10V, V _{DS} =640V, I _D =6A		21	30	nC
Gate to Source Charge		Q_GS	(Note 1, 2)		6		nC
Gate to Drain Charge		Q_{GD}	(14010-1, 2)		9		nC
Turn-ON Delay Time		t _{D(ON)}			26	60	ns
Rise Time		t _R	V_{DD} =400V, I_D =6A, R_G =25 Ω		65	140	ns
Turn-OFF Delay Time		t _{D(OFF)}	(Note 1, 2)		47	105	ns
Fall-Time		t _F			44	90	ns
SOURCE- DRAIN DIODE RATING	S AND CH	ARACTERISTI	CS				
Maximum Body-Diode Continuous Current		I _S				6	Α
Maximum Body-Diode Pulsed Current		I _{SM}				22	Α
Drain-Source Diode Forward Voltage		V _{SD}	I _S =6A, V _{GS} =0V			1.4	V
Reverse Recovery Time		t _{rr}	I_S =6A, V_{GS} =0V, dI_F/dt =100A/ μ s (Note 1)		615		ns
Reverse Recovery Charge		Q_{RR}			5.4		μC

Note: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%

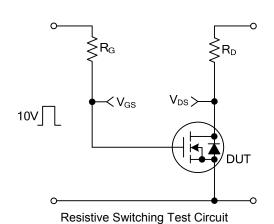
^{2.} Essentially independent of operating temperature

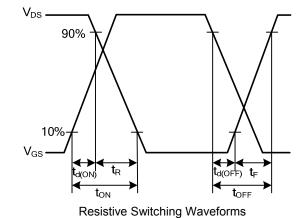
■ TEST CIRCUITS AND WAVEFORMS

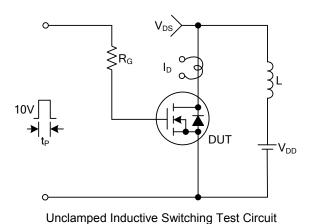


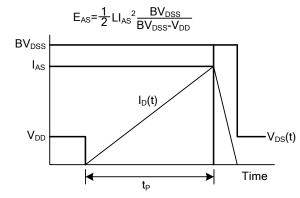


Gate Charge Waveforms



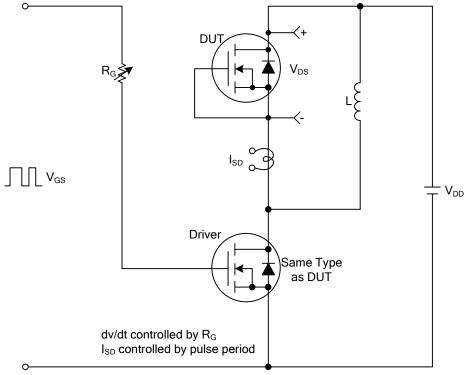




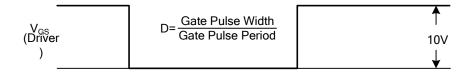


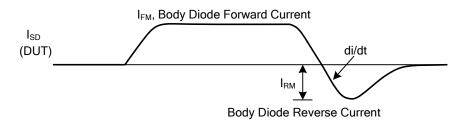
Unclamped Inductive Switching Waveforms

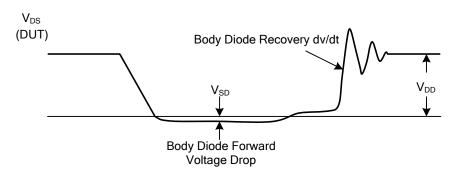
■ TEST CIRCUITS AND WAVEFORMS(Cont.)



Peak Diode Recovery dv/dt Test Circuit & Waveforms







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